

Search Notes

Application/Control No.

10/755,498

Examiner

DuyVu n. Deo

Applicant(s)/Patent under
Reexamination

CHAN ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	303-309	10/31/2005	DVD
438	393-399		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: key words, class/sub (257/303-309; 438/393-399)	10/31/2005	DVD